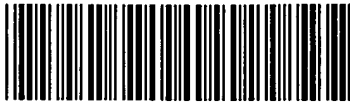


Search Notes

Application/Control No.

10/796,587

Examiner

John S. Chu

Applicant(s)/Patent under
Reexamination

NAIINI ET AL.

Art Unit

1752

SEARCHED

Class	Subclass	Date	Examiner
430	190	7/2005	js
430	191		q
430	192		
430	193		
430	326		
430	18		
528	335,338		
528	339,340		
528	347		
528	348		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH updated	7/2005	js